Issue Classification	on

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/629,402	TANNER, BRIAN K.	
Examiner	Art Unit	
Patrick Miller	2837	

	IS	SSUE CLASSIFICATION		
ORIGINAL		CROSS REFERENCE(S)		
CLASS SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)		
318 471	318	473		
INTERNATIONAL CLASSIFICATION	388	934		
G 0 5 D 23/00	361	25		
H 0 2 H 5/04				
			* "	
			105	
Patrick Miller 10/24/0 (Assistant Examiner) (Date	5	Mala Betch Total Claims Allowe	wed: 10	
DAWK INS	05	ilv25/85 O.G. Print Claim(s) (Primary Examiner): (Déte) /	O.G. Print Fig.	

Patrick Miller

С	Claims renumbered in the same order as presented by applicant								СРА			☐ T.D.			R.1.47				
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
	1		6	31			61			91			121			151			181
	2		8	32			62	1		92			122			152			182
	3		9	33			63			93			123			153			183
	4.		10	34			64	1		94			124		·	154			184
	5	1		35			65			95			125			155			185
	6	1		36			66			96			126		<u>-</u>	156			186
	7	1		37			67			97			127			157			187
	8	]		38			68			98			128			158			188
	9	1		39			69			99			129			159			189
	10	1		40			70			100			130			160		<u> </u>	190
	11	1		41			71			101			131			161			191
	12	1		42			72			102			132			162		<u> </u>	192
	13	1		43			73			103			133			163			193
	14	1		44	1		74	1		104			134			164			194
	15			45			75			105			135	]		165	Ì		195
	16			46			76	1		106			136			166			196
	17			47			77			107			137			167			197
	18	1		48			78			108			138			168			198
	19	1 .		49			79	*		109			139			169			199
	20	1		50			80			110			140			170			200
	21			51		Tan'i	81			111			141			171			201
	22	1		52			82			112			142			172			202
	23			53	1		83			113			143			173			203
	24	1		54	1		84	1		114	]		144			174			204
1	25	1		55	1		85	1		115	]		145			175			205
7	26	1		56	1		86	1		116			146			176			206
2	27			57	1		87	1		117			147			177	]		207
3	28	1		58	1		88	1		118	1		148			178			208
4	29	1		59			89	1		119	1		149			179			209
5	30	1		60			90	1		120			150	<u> </u>		180			210